Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1	"20040145387"	US-PGPUB; USPAT	OR	ON	2006/03/16 14:17
S2	4876	324/765,158.1.ccls.	US-PGPUB; USPAT	OR	ON	2005/02/22 14:47
Ş3	2715	324/765.ccls.	US-PGPUB; USPAT	OR	ON	2005/02/22 14:47
S4	2651	324/158.1.ccls.	US-PGPUB; USPAT	OR	ON	2005/02/22 14:47
S5	490	S3 and S4	US-PGPUB; USPAT	OR	ON	2005/02/22 14:47
S6	42	S5 and load\$4 and unload\$4	US-PGPUB; USPAT	OR	ON	2005/02/22 14:48
S7	16	S5 and load\$4 and unload\$4 and sort\$4	US-PGPUB; USPAT	OR	ON	2005/02/22 14:48
S8	1	"20040112142"	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:54
S9	1	"20010026152"	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:57
S10	2.	"6462534"	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:52
S1,1	1	"20030115519"	US-PĢPUB; USPAT	OR	OFF	2005/05/23 18:03
S12	1	"20040119491"	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:44
S13	1	"20050007140"	US-PGPUB; USPAT	OR	OFF	2005/05/23 18:04
S14	1	"20040207387"	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:46
S15	6	(bang near jeong).in. and scan	US-PGPUB; USPAT	OR	OFF	2005/05/23 15:05
S16	13	(bang near jeong).in. and scan\$4	US-PGPUB; USPAT	OR	OFF	2005/05/23 18:06
S17	0	(bang near jeong).in. and scan\$4 and burn adj in	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:48
S18	1	(bang near jeong).in. and scan\$4 and burn\$2in	US-PGPUB; USPAT	OR	OFF	2005/05/23 14:48
S19	0	(S8 S9 S10 S11 S12 S13 S14)	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:52
S20	0	(S8 S9 S10 S11 S12 S13 S14) scan	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:54
S21	0	S8 scan	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:54

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S22	0	S9 scan\$4	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:53
S23	0	S8 scan\$4	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:53
S24	. 0	S10 scan\$4	US-PGPUB; USPAT	AND .	OFF	2005/05/23 14:53
S25	0	S11 scan\$4	US-PGPUB; USPAT	AND	OFF ·	2005/05/23 14:53
S26	0	S12 scan\$4	US-PGPUB; USPAT	AND ·	OFF	2005/05/23 14:53
S27	0	S13 scan\$4	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:53
S28	0	S14 scan\$4	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:53
S29	0	(S8 S9 S10 S11 S12 S13 S14) package	US-PGPUB; USPAT	AND .	OFF	2005/05/23 14:54
S30	1	S8 package	US-PGPUB; USPAT	AND	OFF	2005/05/23 14:55
S31	1	S8 package	US-PGPUB; USPAT	AND	ON	2005/05/23 14:55
S32	13	(bang near jeong).in. and scan\$4	US-PGPUB; USPAT	OR	OFF	2005/05/23 15:06
S33	3	(bang near jeong).in. and scan\$4 and program	US-PGPUB; USPAT	OR	OFF	2005/05/23 15:06
S34	3	(bang near jeong).in. and scan\$4 and program	US-PGPUB; USPAT	OR	ON	2005/05/23 15:06
S35	1812	burn\$1in and mask\$4 -	US-PGPUB; USPAT	OR	OFF	2005/05/23 15:20
S36	67	(burn\$1in and mask\$4).ab,clm.	US-PGPUB; USPAT	OR	OFF	2005/05/23 15:20
S37	10728	sram same dram	USPAT	OR	OFF	2005/05/23 17:30
S38	186	439/81.ccls.	USPAT	OR	OFF	2005/05/23 17:08
S39	511	sram same dram same test\$4	USPAT	OR	OFF	2005/05/23 17:30
S40	28	sram same dram same test\$4 same multiplex\$4	USPAT	OR	OFF	2005/05/23 17:32
S41	733	365/201.ccls. and (mux multiplex\$4)	USPAT	OR	OFF	2005/05/23 17:33
S42	123	365/201.ccls. and (mux multiplex\$4) and sram and dram	USPAT	OR	OFF	2005/05/23 17:33
S43	18	365/201.ccls. and (mux multiplex\$4) and sram and dram and burn\$4	USPAT	OR ·	OFF	2005/05/23 17:48

						
S44	8	324/760.ccls. and test\$4 with (different multiple) with types with semiconductor	USPAT	OR	OFF	2005/05/23 17:55
S45	9	365/201.ccls. and test\$4 with (different multiple) with types with semiconductor	USPAT	OR	OFF	2005/05/23 17:55
S46	7	(bang near jeong).in. and multiplex\$4	US-PGPUB; USPAT	OR	OFF	2005/05/23 18:08
S47	1103	multiplex\$4 same masking	US-PGPUB; USPAT	OR	OFF	2005/05/23 18:09
S48	44	multiplex\$4 same masking and burn\$4	US-PGPUB; USPAT	OR	OFF	2005/05/23 18:09
S49	37	(test\$4 with multi\$1chip).ti.	USPAT	OR	OFF	2005/05/25 15:11
S50	26	(test\$4 with multi adj chip).ti.	USPAT	OR ·	OFF	2005/05/25 15:23
S51	25	S49 and S50	USPAT	OR	OFF	2005/05/25 15:08
S52	1	S50 not S51	USPAT	OR	OFF	2005/05/25 15:08
S53	4	(test\$4 with multi\$1chip with type). ti.	USPAT	OR .	OFF	2005/05/25 15:09
S54	10	(test\$4 with multi\$1chip).ti. and burn-in	USPAT	OR	OFF	2005/05/25 15:11
S55	1	(test\$4 with multi\$1chip).ti. and burn adj in	USPAT	OR	OFF	2005/05/25 15:11
S56	0	(test\$4 with multi adj chip).ti. and nurn-in	USPAT	OR	OFF	2005/05/25 15:21
S57	6	(test\$4 with multi adj chip).ti. and burn-in	USPAT	OR	OFF	2005/05/25 15:21
S58	3	(test\$4 with mcm).ti.	USPAT	OR	OFF	2005/05/25 15:24
S59	0	test\$4 with different with temperature same multi adj cipp	USPAT	OR	OFF	2005/05/25 15:25
S60	0	test\$4 with different with temperature same multi adj chip	USPAT	OR	OFF	2005/05/25 15:26
S61	0	test\$4 with different with temperature same multi-chip	USPAT	OR	OFF	2005/05/25 15:26
S62	0	test\$4 with different with temperature same mcm	USPAT	OR _.	OFF	2005/05/25 15:26
S63	. 0	test\$4 with different with temperature same mcm	USPAT	OR	ON	2005/05/25 15:26
S64	0	test\$4 with different with temperature same mcm	US-PGPUB; USPAT	OR	ON	2005/05/25 15:26
S65	1	test\$4 with different with temperature same multi-chip	US-PGPUB; USPAT	OR	OFF	2005/05/25 15:26
S66	1	test\$4 with different with temperature same multi adj chip	US-PGPUB; USPAT	OR	OFF	2005/05/25 15:26

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. 1	test\$4 same different with temperature same multi adj chip	US-PGPUB; USPAT	OR	OFF	2005/05/25 15:27
0	test\$4 same different with temperature same multi adj chip	USOCR	OR	OFF	2005/05/25 15:27
	test\$4 same different with temperature same multi adj chip	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/25 15:27
2	different with temperature same multi adj chip	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/07 14:04
0	temperature same different with type with multi adj chip	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/25 15:28
2	different with type with multi adj chip	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/25 15:29
87	different with type with multi adj chip	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/25 15:29
6	S73 and "324"/\$.ccls.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/25 15:30
7	("4556975").PN. OR ("6198663"). URPN.	US-PGPUB; USPAT; USOCR	OR .	OFF	2005/05/25 15:39
57	324/760.ccls. and (mcm (multi adj chip))	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/25 15:40
5	324/760.ccls. and (mcm (multi adj chip)) and different with temperature	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/25 15:41
52	S76 not S77	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/25 15:54
132	257/48.ccls. and burn-in	US-PGPUB; USPAT; USOCR	OR .	OFF	2005/05/25 15:54
10	257/48.ccls. and burn-in and different with temperature	US-PGPUB; USPAT; USOCR	OR	ON .	2005/05/25 15:54
1	(SDRAM DRAM different temperature).clm.	US-PGPUB; USPAT	AND	ON	2005/05/26 16:55
0	(SDRAM DRAM different with temperature).clm.	US-PGPUB; USPAT	AND	ON .	2005/05/26 17:12
23	(test\$4 plurality with semiconductor different with temperature).clm.	US-PGPUB; USPAT	AND	ON	2005/05/26 17:00
	0 0 2 87 6 7 57 5 132 10 1	temperature same multi adj chip test\$4 same different with temperature same multi adj chip test\$4 same different with temperature same multi adj chip different with temperature same multi adj chip temperature same different with type with multi adj chip different with type with multi adj chip different with type with multi adj chip for stripping stripping stripping stripping stripping stripping temperature same different with type with multi adj chip different with type with multi adj chip Stripping stripp	temperature same multi adj chip test\$4 same different with temperature same multi adj chip test\$4 same different with temperature same multi adj chip different with temperature same multi adj chip temperature same multi adj chip different with temperature same multi adj chip temperature same different with type with multi adj chip fip fip different with type with multi adj chip sypant; US-PGPUB; US-PGPUB; US-PGPUB; US-PAT; USOCR fup different with type with multi adj chip) and different with type with multi adj chip) bypant; US-PGPUB;	temperature same multi adj chip test\$4 same different with temperature same multi adj chip test\$4 same different with temperature same multi adj chip different with temperature same multi adj chip temperature same different with type with multi adj chip temperature same different with type with multi adj chip 7 different with type with multi adj chip 87 different with type with multi adj chip 87 different with type with multi adj chip 87 different with type with multi adj chip 88 different with type with multi adj chip 89 different with type with multi adj chip 80 different with type with multi adj chip 81 different with type with multi adj chip 82 different with type with multi adj chip 83 different with type with multi adj chip 84 different with type with multi adj chip 85 different with type with multi adj chip 86 different with type with multi adj chip 87 different with type with multi adj chip 88 different with type with multi adj chip 89 different with type with multi adj chip 89 different with type with multi adj chip 89 different with type with multi adj chip 80 drawara with type with multi adj chip 80 drawara with type with multi adj chip 80 drawara with type with multi adj chip 81 drawara with type with multi adj chip 82 sady 760.ccls. and (mcm (multi adj chip) 83 drawara with type with multi adj chip 84 different with type with multi adj chip 85 drawara with type with multi adj chip 86 different with type with multi adj chip 87 drawara with type with multi adj chip 88 drawara with type with multi adj chip 89 drawara with type 80 drawara with type 80 drawara with type 80 drawara with type 80 drawara with	temperature same multi adj chip test\$4 same different with temperature same multi adj chip test\$4 same different with temperature same multi adj chip test\$4 same different with temperature same multi adj chip different with temperature same multi adj chip temperature same different with type with multi adj chip temperature same different with type with multi adj chip for DERWENT; IBM_TDB different with type with multi adj chip DERWENT; IBM_TDB different with type with multi adj Chip DERWENT; IBM_TDB for DERWENT; IBM_TDB different with type with multi adj Chip DERWENT; IBM_TDB different with type with multi adj Chip DERWENT; USOCR for CFF chip OR OFF chip OR OFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF different with type with multi adj Chip DERWENT; USOCR for CFF dim different with CFP different with type with multi adj Chip DER

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S85	270	SDRAM DRAM different with temperature	US-PGPUB; USPAT	AND	ON	2005/05/26 17:16
S86	0	SDRAM DRAM different with temperature	USOCR	AND	ON	2005/05/26 17:13
S87	1	SDRAM DRAM different with temperature	EPO; JPO; DERWENT; IBM_TDB	AND	ON	2005/05/26 17:13
S88	108	SDRAM DRAM module different with temperature	US-PGPUB; USPAT	AND .	ON	2005/05/26 17:37
S89	77	SDRAM same DRAM module different with temperature	US-PGPUB; USPAT	AND	ON	2005/05/26 17:52
S90	47	testing adj mcm	US-PGPUB; USPAT	AND	ON	2005/05/26 17:52
S91	4	testing adj mcm sdram dram	US-PGPUB; USPAT	AND	ON	2005/05/26 18:06
S92	15	("5137836" "5539752" "5796746" "5807762" "5817535" "5844803" "5856923" "5907492" "5915231" "5927512" "6067507").PN. OR ("6238942"). URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/26 17:56
S93	0	testing adj muiti-chip adj module sdram dram	US-PGPUB; USPAT	AND	ON	2005/05/26 18:07
S94	. 0	testing adj multi-chip adj module sdram dram	US-PGPUB; USPAT	AND	ON	2005/05/26 18:07
S95	47	testing adj multi-chip adj module	US-PGPUB; USPAT	AND	ON	2005/05/26 18:07
S96	44	S95 not S90	US-PGPUB; USPAT	AND _	ON	2005/05/26 18:07
S97	3	S95 S90	US-PGPUB; USPAT	AND	ON	2005/05/26 18:08
S98	91	S95 or S90	US-PGPUB; USPAT	AND ·	ON ·	2005/05/26 18:09
S99	22	S98 and different adj type	US-PGPUB; USPAT	AND	ON	2005/05/26 18:26
S10 1	20	(test\$4 adj program) (different adj type) (mcm or multi-chip)	US-PGPUB; USPAT	AND	ON	2005/05/26 18:28
S10 2	. 5	(test\$4 adj program) (different adj type) (mcm or multi-chip) temperature	US-PGPUB; USPAT	AND	ON	2005/05/26 18:31
S10 3	15	S101 not S102	US-PGPUB; USPAT	AND	ON	2005/05/26 19:07
S10 4	879	package with multiple with type	US-PGPUB; USPAT	AND	ON	2005/05/26 19:07

S10 5	0	package with multiple with type and dram and dsram and dimm	US-PGPUB; USPAT	AND ·	ON	2005/05/26 19:08
S10 6	0	package with multiple with type and dram and sdram and dimm	US-PGPUB; USPAT	AŅD	ON	2005/05/26 19:08
S10 7	31	package with multiple with type same (dram or sdram or dimm)	US-PGPUB; USPAT	AND	ON	2005/05/26 19:15
S10 8	0	package with multiple with type same (dram or sdram or dimm) and program	US-PGPUB; USPAT	AND	ON	2005/05/26 19:15
S10 9	. 0	package with multiple with type same (dram or sdram or dimm) and programm	US-PGPUB; USPAT	AND	ON	2005/05/26 19:15
S11 0	5	package with multiple with type same (dram or sdram or dimm) and test\$4	US-PGPUB; USPAT	AND	ON ,	2005/05/26 19:35
S11 1	. 4	(US-6214641-\$ or US-5998865-\$ or US-5817535-\$ or US-5723907-\$). did.	USPAT	OR	OFF	2005/05/26 19:31
S11 2	86	("4992849" "4992850" "4996587" "5107328" "5137836" "5162947" "5239198" "5255156" "5280192" "5418687" "5465470" "5477082" "5480840" "5495398" "5610767" "5687028").PN. OR ("5723907" "5817535" "5998865" "6214641").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/26 19:31
S11 . 3	. 0	S112 and sdram and dram and test\$4 and program	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/26 19:32
S11 4	0	S112 and sdram and test\$4 and program	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/26 19:32
S11 5	0	S112 and sdram and test\$4 and program	US-PGPUB; USPAT; USOCR	OR	ON	2005/05/26 19:32
S11 6	.0	S112 and test\$4 and program	US-PGPUB; USPAT; USOCR	OR	ON	2005/05/26 19:32
S11. 7	6	S112 and sdram and dram and test\$4	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/26 19:33
S11 8	1	package with multiple with type same (dram or sdram) and test\$4	US-PGPUB; USPAT	AND	ON	2005/05/26 19:39
S11 9	0	(test\$4 with (simm or dimm) with sdram dram).ti.	US-PGPUB; USPAT	AND	ON	2005/05/26 19:40

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S12 0	0	(test\$4 with (simm or dimm)).ti.	US-PGPUB; USPAT	AND	ON	2005/05/26 19:40
S12 1	9	(test\$4 with (simm or dimm)).ab.	US-PGPUB; USPAT	AND	ON	2005/05/26 19:40
S12. 2	0	257/777.ccls. and (sram with dram with non\$1volatile)	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/07 14:06
S12 3	0	257/777.ccls. and (sram with dram or non\$1volatile)	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/07 14:06
S12 4	0	257/777.ccls. and (sram with dram)	EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/07 14:06
S12 5	6	257/777.ccls. and (sram with dram with non\$1volatile)	US-PGPUB; USPAT; USOCR	OR .	OFF	2005/10/07 14:06
S12 6	6	257/777.ccls. and (sram with dram with non\$1volatile)	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:26
S12 7	· 0	257/777.ccls. and (sram with dram with test\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:14
S12 8	386	(sram with dram with test\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:14
S12 9	· 20	(sram with dram with test\$4 with package\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07,14:14
S13 0	5	(sram with dram with test\$4 with package\$4 and temperature)	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:15
S13 1	32	("4503537" "4513418" "5255229" "5297087" "5375091" "5381373" "5390129" "5424988" "5535164" "5557573" "5563833" "5577051" "5590079" "5592422" "5610866" "5615164" "5619462" "5629943" "5633877" "5638331" "5654925" "5657282" "5659551" "5668770").PN. OR ("6122760").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/10/07 14:19
S13 2	59	257/777.ccls. and (test\$4).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:54
S13 3	0	257/777.ccls. and (test\$4 with different with temperature).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:54

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S13 4	. 2	257/777.ccls. and (test\$4 with temperature).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:42
S13 -	1	"6198663".pn.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:47
S13 6	1	"5931311".pn.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:47
S13 7	0	257/777.ccls. and (test\$4 and different with temperature).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:55
S13 8	0	257/777.ccls. and (test\$4 and program and temperature).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:55
S13 9	1	257/777.ccls. and (test\$4 and program).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/07 14:55
S14 0	. 1	"6014316".pn.	USPAT	OR	OFF	2005/10/16 14:43
S14 1	. 74	mask\$4 adj function with block\$4	USPAT	OR	OFF	2005/10/16 17:18
S14 2	. 0	mask\$4 adj function with block\$4 and burn\$1in	USPAT	OR	OFF	2005/10/16 17:18
S14 3	0	mask\$4 adj function with block\$4 and burn adj in	USPAT	OR	OFF	2005/10/16 17:18
S14 4	. 2	mask\$4 adj function with block\$4 and burn	USPAT	OR	OFF	2005/10/16 17:19
S14 5	.13	mask\$4 adj function with block\$4 and test	USPAT	OR	OFF	2005/10/16 17:19
S14 6	25	mask\$4 adj function with block\$4 and test	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2005/10/16 17:19
S14 7	31	mask\$4 adj function with block\$4 and test\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:19
S14 8	17	mask\$4 adj function with block\$4 and test\$4 and (semiconductor or integrated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:19

S15 0		S145 and (semiconductor or integrated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:22
S15 1	12	S148 not S150	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:27
S15 2	1	test adj program with block\$4 adj function	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:28
\$15 3	1	test adj program with block\$4 adj function	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/16 17:28
S15 4	143	program with block\$4 adj function	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:28
S15 5	61	program with block\$4 adj function and (semiconductor or integrated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:29
S15 6	36	program with block\$4 adj function and (semiconductor or integrated) and test\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:31
S15 7	1	program with block\$4 adj function and (semiconductor or integrated) and test\$4 and burn\$1in	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:29

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S15 8	41	program with block\$4 adj function and package and test\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/16 17:30
S15 9	24	S156 and S158	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/16 17:30
S16 0	7	program with mask\$4 adj function and (semiconductor or integrated) and test\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:58
S16 1	1	S159 and S160	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:31
S16 2	1	2004-362653.NRAN.	DERWENT	OR	OFF	2005/10/16 17:53
S16 3		kr2004001017a	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:59
S16 4	1	KR2004001017A	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/10/16 17:59
S16 5	1	"20040216006"	US-PGPUB; USPAT	OR	ON.	2006/03/16 14:22
S16 6	3	"6563070"	US-PGPUB; USPAT	OR	ON	2006/03/16 14:23
S16 7	. 0	(test\$4 with simm).ti.	USPAT	OR	OFF	2006/04/10 19:33
S16 8	0	(test\$4 with dimm).ti.	USPAT	OR	OFF	2006/04/10 19:33

S16 9	115	(test\$4 with dimm)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:33
S17 0	63	(test\$4 with simm)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:33
S17 1	15	(test\$4 near2 simm)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:33
S17 2	29	(test\$4 near2 dimm)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:34
S17 3	40	S171 or S172	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:34
S17 4	0	S173 and different near temperature	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:34
S17 5	11	(different near temperature) and (simm or dimm)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:35
S17 6	. 147	(different near temperature) and (sram)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF '	2006/04/10 19:38
S17 7	0	(different near temperature) with (sram)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:35
S17 8	95	S176 and (test\$4 or burn-in)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:38

		EAST Scare				
S17 9	. 95	(different near temperature) and (sram) and (test\$4 or burn-in)	US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:39
S18 0	186	(different near temperature) and (sram) and (test\$4 or burn-in)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF a	2006/04/10 19:39
S18 1	91	S180 not S179	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 19:43
S18 2	8	S181 and mcm	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/04/10 20:04
S18 3	. 2	(("5239747") or ("5461544")).PN.	USPAT	OR	OFF	2006/04/10 20:14
S18 4	.0	((uploading with program) and (mcm or sram or dram)).clm.	USPAT	OR	OFF	2006/04/10 20:15
S18 5	0	((upload\$4 with program) and (mcm or sram or dram)).clm.	USPAT	OR	OFF	2006/04/10 20:15
S18 6	202	((upload\$4 with program) and (mcm or sram or dram))	USPAT	OR	OFF	2006/04/10 20:15
S18 7	4	((upload\$4 with program) with (mcm or sram or dram))	USPAT	OR _.	OFF	2006/04/10 20:18
S18 8	281	((load\$4 with program) with (mcm or sram or dram))	USPAT	OR	OFF	2006/04/10 20:52
S18 9	3	((load\$4 with program) with (mcm or sram or dram)).clm.	USPAT	OR	OFF	2006/04/10 20:39
S19 0	3	((load\$4 with test\$4 near program) with (mcm or sram or dram))	USPAT .	OR	OFF	2006/04/10 20:49
S19 1	0	((load\$4 with test\$4 near program) with (mcm)).clm.	USPAT	OR	OFF	2006/04/10 20:49
S19 2	0	((upload\$4 with test\$4 near program) with (mcm)).clm.	ÜSPAT	OR	OFF	2006/04/10 20:49
S19 3	0	((upload\$4 with test\$4 near program) with (module)).clm.	USPAT	OR	OFF	2006/04/10 20:49
S19 4	4	((load\$4 with test\$4 near program) with (module)).clm.	USPAT	OR .	OFF	2006/04/10 20:49

S19 5	73	((load\$4 with program) with (mcm or sram or dram)) and semiconductor	USPAT	OR	OFF	2006/04/10 21:04
S19 6	13	S195 and temperature	USPAT	OR	OFF	2006/04/10 21:05

S19	91	(US-20040145387-\$ or	US-PGPUB;	OR	OFF	2006/05/11 17:06
7		US-20010026152-\$ or	USPAT;			
		US-20050099199-\$ or	DERWENT			
		US-20030061528-\$ or				
		US-20040230932-\$ or				:
		US-20030137860-\$ or				
		US-20020109221-\$ or				
		US-20020064033-\$ or			(
		US-20010049157-\$ or			`	
		US-20040026791-\$ or				
		US-20030207495-\$ or				
		US-20050104194-\$ or				
						·
		US-20050002246-\$ or	1			
	1	US-20040038450-\$ or				
		.US-20040178488-\$ or				
		US-20050153465-\$ or				·
		US-20040164385-\$).did. or				
		(US-5414370-\$ or US-6762486-\$ or				
		US-6680212-\$ or US-5998860-\$ or				
		US-6856009-\$ or US-6150724-\$ or				
		US-6006347-\$ or US-5301155-\$ or				
	·	US-4926117-\$ or US-6246618-\$ or				
		US-6703854-\$ or US-5406212-\$ or				
		US-6288958-\$ or US-6198663-\$ or				
		•				
		US-5953285-\$ or US-5936977-\$ or				
		US-5781789-\$ or US-6286118-\$ or				
		US-6697978-\$ or US-6161205-\$ or	:			
		US-6119255-\$ or US-5461544-\$ or				
		US-5239747-\$ or US-6754849-\$ or				
		US-6577979-\$ or US-5519715-\$).				
		did. or (US-6236952-\$ or				
		US-5892949-\$ or US-5748532-\$ or			· .	
		US-5701309-\$ or US-5459684-\$ or				
		US-5157664-\$ or US-6483333-\$ or				
		US-5243498-\$ or US-5959310-\$ or				
		US-5931311-\$ or US-6091079-\$ or				
		US-6728653-\$ or US-6087676-\$ or				
		US-5473259-\$ or US-6016282-\$ or			f	
		· ·				
		US-6395565-\$ or US-5817535-\$ or				
		US-5956233-\$ or US-6238942-\$ or				
		US-6725115-\$ or US-6754129-\$ or				
		US-6897553-\$ or US-6884654-\$ or				'
		US-6707141-\$ or US-6677671-\$ or				
		US-6656767-\$ or US-6445063-\$).				
		did. or (US-6329221-\$ or				
		US-6300163-\$ or US-6214641-\$ or				
		US-6091143-\$ or US-5998865-\$ or				
		US-5936305-\$ or US-5899705-\$ or				
		US-5811879-\$ or US-5723907-\$ or				
		US-6465275-\$ or US-6207474-\$ or	1			
		•				
		US-6104089-\$ or US-6448524-\$ or				1
		US-6357022-\$ or US-6055653-\$ or				
		US-5852617-\$ or US-6178526-\$ or		1		
		US-6122760-\$ or US-6014316-\$).				
		did. or (KR-2004001017-\$ or		1		
	8:12:49_PM_	US-20020014913-\$).did.				Page_1

S19 8	0	S197 and tbga	USPAT	OR	OFF	2006/05/11 17:07
S19 9	. 34	"6014316"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2006/05/11 19:00
S20 <u>0</u>	0	S199 and tbga	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/11 17:07
\$20 1	4578	bipolar near cmos	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR ,	ON	2006/05/11 19:00
S20 2	735	(bipolar near cmos).ti.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/11 19:02
S20 3		(bipolar near cmos).ab.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/11 19:02
\$20 4	96	S202 and S203	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/05/11 19:02